PRODUCT: TFT TOUCH MODULE

MODULE NO.: WKS35123

WKS

SUPPLIER: WKS Technology Co.,LTD

DATE: Sep 11, 2016

SPECIFICATION

Revision: 0.0

WKS35123

This module uses ROHS material

This specification may change without prior notice in order to improve performance or quality. Please contact WKS R&D department for updated specification and product status before design for this product or release of this order.

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REVISION RECORD

REV NO.	REV DATE	CONTENTS	REMARKS
0.0	2016-09-11	First release	Preliminary

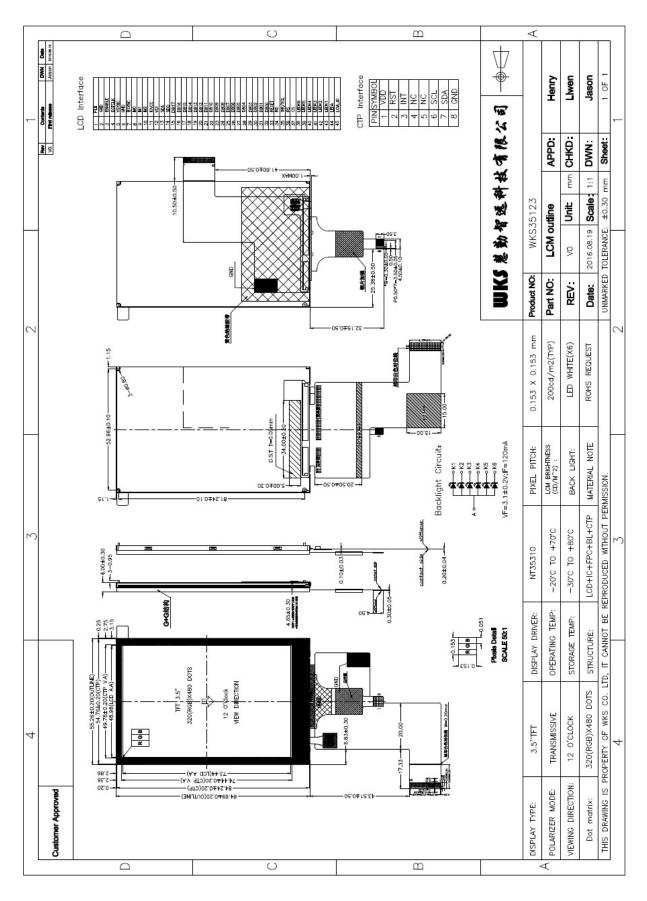
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1. GENERAL INFORMATION

Item of general information	Contents	Unit
LCD Display Size (Diagonal)	3.5	inch
LCD Display Type	TFT/TRANSMISSIVE	-
LCD Display Mode	Normally White	-
Recommended Viewing Direction	6	o'clock
Gray inversion Direction	12	o'clock
$Module\ size\ (W imes H imes T)$	55.26×84.69×4.00	mm
Active area (W×H)	48.96×73.44	mm
Number of pixels (Resolution)	320RGB×480	pixel
Pixel pitch (W×H)	0.153×0.153	mm
Color Pixel Arrangement	RGB Stripe	-
LCD Driver IC	-	-
CTP Driver IC	-	-
Interface Type	8080 interface/RGB interface	-
Power consumption	<u>-</u>	mA
Color Numbers	65K/262K	-
Backlight Type	White LED	-

2, EXTERNAL DIMENSIONS



3, ABSOLUTE MAXIMUM RATINGS

Parameter of absolute maximum ratings	Symbol	Min	Max	Unit
LCD supply walkings	VCI	-0.3	5.5	V
LCD supply voltage	IOVCC	-0.3	5.5	V
Operating temperature	Тор	-20	70	$^{\circ}\!C$
Storage temperature	Tst	-30	80	$^{\circ}\!C$
Humidity	RH	-	90%(Max 60°C)	RH

Note: Absolute maximum ratings mean the product can withstand short-term, not more than 120 hours. If the product is a long time to withstand these conditions, the life time would be shorter.

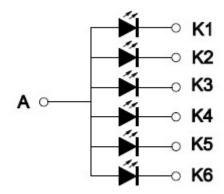
4, ELECTRICAL CHARACTERISTICS(DC CHARACTERISTICS)

Parameter of DC	Symbol	Min.	Тур.	Max.	Unit	
characteristics	v					
Analog operating voltage	VCI	2.3	2.8	3.3	V	
I/O operating voltage	IOVCC	1.65	1.8	3.3	V	
LCD Input Current	Idd	-	-	-	mA	
Input voltage 'H' level	VIH	0.7*IOVCC	-	IOVCC	V	
Input voltage 'L' level	VIL	VSS	-	0.2*IOVCC	V	
Output voltage 'H' level	VOH	0.8*IOVCC	-	IOVCC	V	
Output voltage 'L' level	VOL	VSS	-	0.2IOVCC	V	

5, BACKLIGHT CHARACTERISTICS

Item of backlight characteristics	Symbol	Min.	Тур.	Max.	Unit	Remark
Forward voltage	Vf	2.9	3.1	3.3	V	Note1
Forward Current	If	-	120	-	mA	-
Number of LED	-	-	6	-	Piece	-
LED Connection mode	P/S	-	Parallel	-	-	-
Lifetime of LED	-	-	10000	-	hour	Note2

- ➤ Note1: The LED Supply Voltage is defined by the number of LED at Ta=25°C and If=120mA.
- Note2: The LED lifetime define as the estimated time to 50% degradation of initial luminous. The LED lifetime could be decreased if operating If is larger than 120mA.
- > Backlight circuit:



VF=3.1±0.2V;IF=120mA(Typ.)

6, CTP CHARACTERISTICS

Item of CTP characteristics	Specification	Unit	Remark
Panel Type	Cover Lens + ITO Glass	-	-
Resolution	320×480	pixel	-
Surface Hardness	<i>≥</i> 6H	-	-
Transparency	>85%	-	-
Driver IC	-	-	-
Interface Type	I2C	-	-
Support Points	5(Max)	-	-
Supply voltage	3.3	V	-

7、ELECTRO-OPTICAL CHARACTERISTICS

Item o electro-op character	otical	Symbol	Condition	Min.	Тур.	Max.	Unit	Remark	Note
Response	time	Tr+Tf		-	16	32	ms	FIG 1.	4
Contrast I	Ratio	CR	$\theta=0$	_	400	-	-	FIG 2.	1
Luminance un	iformity	<i>SWHITE</i>	$\mathcal{D}=0$ $Ta=25^{\circ}C$	-	80	-	%	FIG 2.	3
Surface Lum	inance	Lv	14 23 0	-	200	-	cd/m2	FIG 2.	2
	W71.:4 a	White x		-	0.303	-		FIG 2.	
	White	White y		-	0.325	-			5
	D a d	Red x		-	0.626	-			
CIE(x, y)	Red	Red y	$\theta=0$	-	0.334	-			
chromaticity	C	Green x	$\mathcal{D}=0$ $Ta=25^{\circ}C$	-	0.277	-			3
	Green	Green y	14 25 C	-	0.549	-			
	D.I	Blue x		-	0.142	-			
	Blue	Blue y		-	0.122	-			
	Ø=90(1	2 o'clock)		-	70	-	deg		
Viewing	Ø=270	(6 o'clock)	GD : 10	-	60	-	deg deg	FIG 3.	
angle range	Ø=0(3	o'clock)	CR ≥ 10	-	70	-		FIG 3.	6
	Ø=180 ₀	(9 o'clock)		-	70	-	deg		
NTSC ratio		-	-	-	60		%		

Note 1. Contrast Ratio(CR) is defined mathematically by the following formula. For more information see FIG 2.

 $Contrast\ Ratio(CR) = \frac{Average\ Surface\ Luminance\ with\ all\ white\ pixels(P1,P2,P3,P4,P5,P6,P7,P8,P9)}{Average\ Surface\ Luminance\ with\ all\ black\ pixels(P1,P2,P3,P4,P5,P6,P7,P8,P9)}$

Note 2. Surface luminance is the LCD surface from the surface with all pixels displaying white. For more information see FIG 2.

Lv=Average Surface Luminance with all white pixels (P1,P2,P 3,P4, P5,P6,P7,P8,P9)

Note 3. The uniformity in surface luminance $(\delta WHITE)$ is determined by measuring



luminance at each test position 1 through 9, and then dividing the maximum luminance of 9 points luminance by minimum luminance of 9 points luminance. For more information see FIG 2.

$$\delta \text{WHITE} = \frac{Minimum \, Surface \, Luminance \, with \, all \, white \, pixels \, (P1, P2, P3, P4, P5, P6, P7, P8, P9)}{Maximum \, Surface \, Luminance \, with \, all \, white \, pixels \, (P1, P2, P3, P4, P5, P6, P7, P8, P9)}$$

Note 4. Response time is the time required for the display to transition from White to black(Rise Time, Tr) and from black to white(Decay Time, Tf). For additional information see FIG 1.

Note 5. CIE (x, y) chromaticity, The x,y value is determined by screen active area position 5. For more information see FIG 2.

Note 6. Viewing angle is the angle at which the contrast ratio is greater than a specific value. For TFT module, the specific value of contrast ratio is 10. The angles are determined for the horizontal or x axis and the vertical or y axis with respect to the z axis which is normal to the LCD surface. For more information see FIG 3.

Note 7. For Viewing angle and response time testing, the testing data is base on Autronic-Melchers's ConoScope. Series Instruments. For contrast ratio, Surface Luminance, Luminance uniformity and CIE, the testing data is base on BM-7 photo detector.

Note 8. For TN type TFT transmissive module, Gray scale reverse occurs in the direction of panel viewing angle.

FIG.1. The definition of Response Time

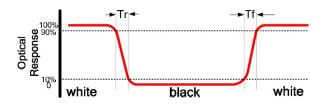


FIG.2. Measuring method for Contrast ratio, surface luminance, Luminance uniformity,

CIE(x, y) chromaticity

A: H/6; B: V/6;

H,V: Active Area(AA) size

Measurement instrument: BM-7; Light spot size=5mm, 350mm distance from the LCD surface to detector lens.

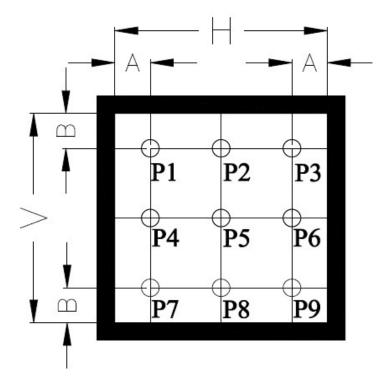
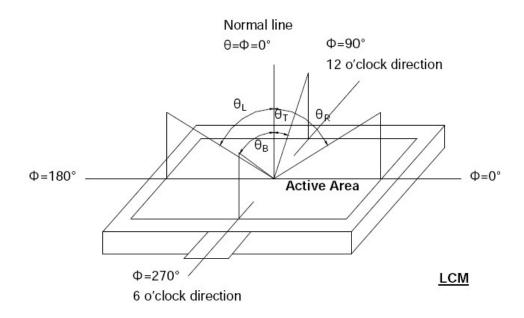


FIG.3. The definition of viewing angle





8. INTERFACE DESCRIPTION

A. LCD Interface Description

NO.	Symbol	I/O	DESCRIPTION
1	FMARK	0	Frame head pulse signal. Utilize this signal when synchronizing
1	(TE)	O	RAM data write operations. If not used, please open this pin.
2	GND	Power supply	Power ground
3	<i>ENABLE</i>	I	Data input Enable. Active high to enable the data input Bus.
4	DCLK	I	Clock signal. Latching data at the rising edge.
5	VSYNC	I	Vertical Sync input. Negative polarity.
6	GND	Power supply	Power ground
7	HSYNC	I	Horizontal Sync input. Negative polarity.
8	IM0	I	
9	IM1	I	Selects the interface to MPU
10	IM2	I	
11	IOVCC	Power supply	Power supply to the I/O.IOVCC=1.65~3.3V
12	VCI	Power supply	Power supply to the liquid crystal power supply analog circuit. $VCI=2.3\sim3.3V$
13	SDA	I	Serial data input or output signal in serial interface mode
14	SDO	0	Serial data output when SDA_EN=0
15~32	DB17~DB0	I	Data Bus
33	RESET	I	LCD RESET signal, Low is active
34	RD	I	Read strobe signal
35	WR/SCL	I	WR: Write strobe signal in the 8080-MCU interface
33	WINSCL	I	SCL: A synchronous clock signal in serial interface
36	RS	I	Data/Command select
37	CS	I	Chip select
38	LED-K6	Power supply	Backlight Cathode
39	LED-K5	Power supply	Backlight Cathode
40	<i>LED-K4</i>	Power supply	Backlight Cathode
41	LED-K3	Power supply	Backlight Cathode
42	LED-K2	Power supply	Backlight Cathode
43	LED-K1	Power supply	Backlight Cathode
44	LED-A	Power supply	Backlight Anode
45	LCM_ID	0	Open

Note1:3wire or 4wire serial interface selection for B3h register:

SDA_EN	Input Pin	Output Pin
0	SDA	SDO
1	SDA	SDA

Note2: IM0~IM3:

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IM2	IM1	IM0	Interface Selection
0	0	0	18bit 8080 interface
0	0	1	9bit 8080 interface
0	1	0	16bit 8080 interface
0	1	1	8bit 8080 interface
1	0	0	MDDI+9bit serial interface
1	0	1	9bit serial interface + RGB interface
1	1	0	MIPI interface
1	1	1	8bit serial interface + RGB interface

B. CTP Interface Description

NO.	Symbol	I/O DESCRIPTION	
1	VDD	Power supply	CTP Power input
2	RESET	I	CTP external reset signal, Low is active
3	INT	0	CTP External interrupt to the host
<i>4</i> ~5	NC	-	No connection
6	SCL	I	CTP 12C clock input
7	SDA	I/O	CTP I2C data input and output
8	GND	Power supply	Power Ground

9, INPUT TIMING

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80-System Bus Interface Timing Characteristics (Register Access)

Item	Symbol	Min	Тур.	Max	Unit
Write cycle time	tWC	40	-	-	ns
Read cycle time	tRC	400	-	-	ns
Write control pulse "Low" duration	tWRL	19	-	-	ns
Read control pulse "Low" duration	tRDL	150	-	-	ns
Write control pulse "High" duration	tWRH	19	-	-	ns
Read control pulse "High" duration	tRDH	250	-	-	ns
Write setup time(DCX to CSX,WRX)	tAST	0	-	-	ns
Read setup time(DCX to CSX,RDX)	tAST	10	-	-	ns
Address hole time	tAHT	2	-	-	ns
Write data setup time	tDST	10	-	-	ns
Write data hold time	tDHT	10	-	-	ns
Read data access time	tRAT	-	-	150	ns
Read data hold time	tODH	5	-	-	ns
Chip select setup time	tCS	15	-	-	ns

80-System Bus Interface Timing Characteristics (RAM Data Access)

Item	Symbol	Min	Тур.	Max	Unit
Write cycle time	tWC	40	-	-	ns
Read cycle time	tRC	160	-	-	ns
Write control pulse "Low" duration	tWRL	19	-	-	ns
Read control pulse "Low" duration	tRDL	45	-	-	ns
Write control pulse "High" duration	tWRH	19	-	-	ns
Read control pulse "High" duration	tRDH	90	-	-	ns
Write setup time(DCX to CSX, WRX)	tAST	0	-	-	ns
Read setup time(DCX to CSX,RDX)	tAST	10	-	-	ns
Address hole time	tAHT	2	-	-	ns
Write data setup time	tDST	15	-	-	ns
Write data hold time	tDHT	10	-	-	ns
Read data access time	tRAT	-	-	40	ns
Read data hold time	tODH	5	-	-	ns
Chip select setup time	tCS	15	-	-	ns

10, RELIABILITY TEST CONDITIONS

No.	Test Item	Test Condition
1	High Temperature Storage	80°C/120 hours
2	Low Temperature Storage	-30°C/120 hours
3	High Temperature Operating	70°C/120 hours
4	Low Temperature Operating	-20°C/120 hours
5	Temperature Cycle Storage	-20°C(30min.)~25(5min.)~70°C(30min.)×10cycles

A. Inspection after test:

Inspection after 2~4 hours storage at room temperature, the sample shall be free from defects:

- ➤ Air bubble in the LCD;
- > Sealleak;
- ➤ Non-display;
- Missing segments;
- ➤ Glass crack;
- Current is twice higher than initial value.

B, Remark:

- The test samples should be applied to only one test item.
- Sample size for each test item is 5~10pcs.
- Failure Judgment Criterion: Basic Specification, Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

11 SPECTION CRITERION

This specification is made to be used as the standard of acceptance/rejection criteria for TFT-LCD/IPS TFT-LCD module product, and this specification is applicable only in the case that the size of module equal to or exceed than 3.5 inch.

11.1 Sample plan

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Sampling plan according to GB/T2828.1-2003/ISO 2859-1: 1999 and ANSI/ASQC Z1.4-1993,normal level 2 and based on:

Major defect: AQL 0.65

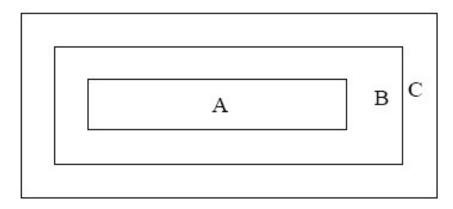
Minor defect: AQL 1.5

11.2 Inspection condition

Viewing distance for cosmetic inspection is about 30cm with bare eyes, and under an environment of $20\sim40W$ light intensity, all directions for inspecting the sample should be within 45° against perpendicular line. (Normal temperature $20\sim25$ ° Cand normal humidity 60 $\pm15\%$ RH)

11.3 Definition of Inspection Item.

A. Definition of inspection zone in LCD.





Zone A: character/Digit area

Zone B: viewing area except Zone A (Zone $A + Zone B = minimum \ Viewing \ area)$

Zone C: Outside viewing area (invisible area after assembly in customer's product)

Fig. 1 Inspection zones in an LCD

Note: As a general rule, visual defects in Zone C are permissible, when it is no trouble for quality and assembly of customer's product.

B. Definition of some visual defect

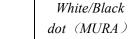
	Because of losing all or part function, bad pixel dots appear bright and the
Bright dot	size is more than 50% of one dot in which LCD panel is displaying under
	black pattern.
Dunk dat	Dots appear dark and unchanged in size in which LCD panel is displaying
Dark dot	under pure red, green, blue picture, or pure whiter picture.

11.4 Major Defect

Item No.	Items to be inspected	Inspection standard	Classification of defects
1	Functional defects	1) No display 2) Display abnormally 3) Missing vertical, horizontal segment 4) Short circuit 5) Excess power consumption 6)Backlight no lighting, flickering and abnormal lighting	major
2	Missing	Missing component	
3	Outline dimension	Overall outline dimension beyond the drawing is not allowed	

11.5 Minor Defect

Item No.	Items to be	Inspection standard					Classification of defects				
		Zone		Acceptable Qty $A+B$							
				3.5~7" 7~10.1"		· >10.1"	С				
		Bright pixel do	_	1	2	3					
	D. t. t.	Dark pixel dot	:	4	4	4	A				
1	Bright dot /dark dot	2bright dots adja	icent	0	0	0	Acceptable	Minor			
1	defect	2dark dots adjac	cent	0	0	0	otab	Minor			
	uejeci	Total bright and dots	dark	5	6	7	ble				
		Note: Minimum dista Pixel dots' function a material and other r	is normal,	but bri	ght dots ca	used by foreig	gn				
	Dot defect y	Zone Acceptable Qty									
			A+B								
		Dot defect y x	Size(mm)	3.5"~		7~10.1"	>10.1"	С			
			Φ≤0.2	Accepta	ible A	cceptable	Acceptable	Acceptable			
2					$0.2 < \Phi \le 0.5$	4		5	6	epta.	Minor
			$\Phi > 0.5$	0		0	0	ble			
Φ=(x+y) /2		Note: 1. Minimum distance 2. The quantity of de		-			m;				
		Zone			1cceptable	Qty					
3	Linear defect	Size (mm)		A+B							
		Length Width	3.5"~	7"	7~10.1"	>10.1"	С	Minor			
		Ignore W≤0.05	Accepta	ble A	cceptable	Acceptable	Ac	Minor			
		$ \begin{array}{ c c c } \hline L \leqslant 5.0 & 0.05 < \\ \hline W \le 0.1 \end{array} $	4		5	6	Acceptable				
		L>5.0 W>0.1	0		0	0	ile				



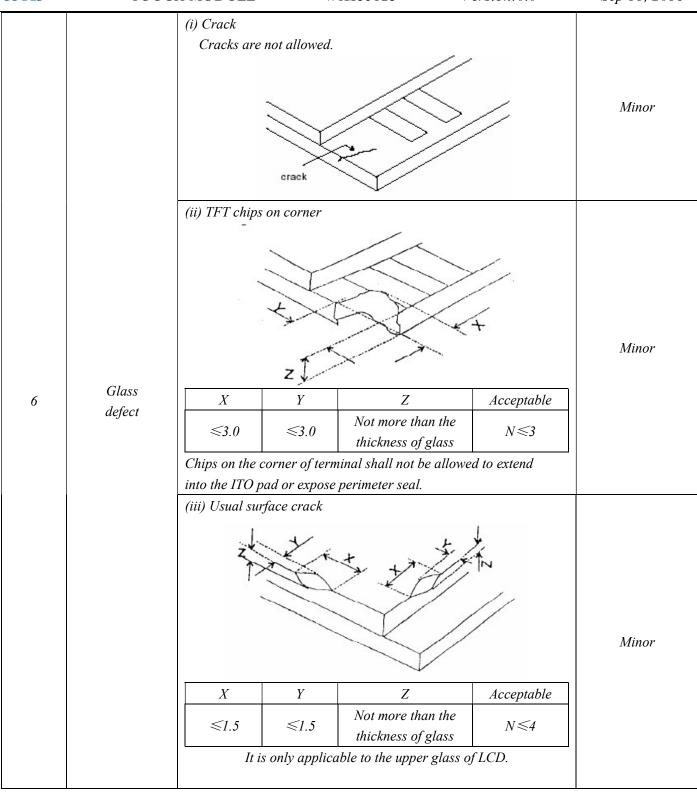
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Visible under: ND3%; $D \le 0.15$ mm, Acceptable;

 $0.15mm < D \le 0.5mm$, $N \le 4$; D > 0.5mm, Not allowable.

Minor





11.6 Module Cosmetic Criteria

Item No.	Items to be Inspection Standard		Classification of defects
1	Difference in Spec.	Not allowable	Major
2	Pattern peeling	No substrate pattern peeling and floating	Major
		No soldering missing	Major
3	Soldering defects	No soldering bridge	Major
		No cold soldering	Minor
4	Resist flaw on PCB	Visible copper foil (Φ 0.5 mm or more) on substrate pattern is not allowed	Minor
5	FPC gold finger	No dirt, breaking, oxidation lead to black	Major
6	Backlight plastic frame	No deformation, crack, breaking, backlight positioning column breaking, obvious nick.	Minor
7	Marking printing effect	No dark marking, incomplete, deformation lead to unable to judge	Minor
8	Accretion of metallic Foreign matter	No accretion of metallic foreign matter (Not exceed Φ0.2mm)	Minor
9	Stain	No stain to spoil cosmetic badly	Minor
10	Plate discoloring	No plate fading, rusting and discoloring	Minor
	1. Lead parts	a. Soldering side of PCB Solder to form a 'Filet' all around the lead. Solder should not hide the lead form perfectly.	Minor
	1. Leau paris	b. Components side(In case of 'Through Hole PCB') Solder to reach the Components side of PCB.	Minor
	2. Flat packages	Either 'Toe'(A) or 'Seal'(B)of the lead to be covered by "Filet". Lead form to be assume over Solder.	Minor
11	3. Chips	(3/2) H ≥h ≥(1/2) H \times_h \times_H	Minor
	4. Solder ball/Solder splash	a. The spacing between solder ball and the conductor or solder pad $h \ge 0.13$ mm. The diameter of solder ball $d \le 0.15$ mm.	Minor
		b. The quantity of solder balls or solder splashes isn't beyond 5 in 600 mm2.	Minor
		c. Solder balls/Solder splashes do not violate minimum electrical clearance.	Major